

# 30V N-Channel Trench MOSFET(Preliminary)

# **General Description**

- Trench Power technology
- Low R<sub>DS(ON)</sub>
- Low Gate Charge
- Optimized for fast-switching applications

### **Applications**

- Synchronous Rectification in DC/DC and AC/DC Converters
- Isolated DC/DC Converters in Telecom and Industrial

#### **Product Summary**

 $V_{DS}$  30V  $I_{D}$  (at  $V_{GS}$ =10V) 160A  $R_{DS(ON)}$  (at  $V_{GS}$ =10V) < 2.2m $\Omega$ 

100% UIS Tested

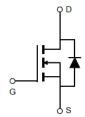
 $R_{DS(ON)}$  (at  $V_{GS} = 4.5V$ )



 $< 3m\Omega$ 







Part Number	Package Type	Form	Marking
TTD160N03GT	TO-252	Tape&Reel	160N03GT
TTP160N03GT	TO-220	Tube	160N03GT

## Absolute Maximum Ratings (T<sub>A</sub> =25°C unless otherwise noted)

Parameter		Symbol	Maximum	Units	
Drain-Source Voltage		V <sub>DS</sub>	30	V	
Gate-Source Voltage		$V_{GS}$	±20	V	
Continuous Prain Current B	T <sub>C</sub> =25°C	1.	105		
Continuous Drain Current B	T <sub>C</sub> =100°C	l <sub>D</sub>	105	Α	
Pulsed Drain Current A		I <sub>DM</sub>	480	А	
Avalanche Current <sup>A</sup>		I <sub>AS</sub>	43	А	
Single Pulse Avalanche Energy L =0.3mH A		E <sub>AS</sub>	277	mJ	
Payer Dissipation C	T <sub>C</sub> =25°C	- P <sub>D</sub>	143	W	
Power Dissipation <sup>C</sup>	T <sub>C</sub> =100°C		71	W	
Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>STG</sub>	-55 to 175	°C	
Thermal Characteristics					

#### Thermal Characteristics

Parameter		Symbol	Maximum	Units	
Maximum Junction-to-Case	Steady-State	$R_{\Theta JC}$	1.1	0004	
Maximum Junction-to-Ambient	Steady-State	$R_{\Theta JA}$	100	°C/W	



⊏iectric	cal Characteristics(T <sub>J</sub> =25°C ur	iless otherwise i	noted)				I
Symbol	Parameter	Conditions		Value			Units
				Min	Тур	Max	
STATIC P	ARAMETERS						
$BV_{DSS}$	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$		30			V
	7 0 1 1/1 5 1 0 1	.,	T <sub>J</sub> =25°C			1	μΑ
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = 30V, V_{GS} = 0V$	T <sub>J</sub> =100°C			25	
I <sub>GSS</sub>	Gate-Body Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 20V$	•			±100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$ , $I_D = 250 \mu A$		1	1.7	2.4	V
D	Chatia Dunin Course On Designation	V <sub>GS</sub> =10V, I <sub>D</sub> =20A			1.7	2.2	mΩ
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	$V_{GS} = 4.5 \text{V}, I_D = 20 \text{A}$			2.3	3	mΩ
g <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> =10V, I <sub>D</sub> =20A			34		S
$V_{SD}$	Diode Forward Voltage	I <sub>S</sub> =10A, V <sub>GS</sub> =0V				1	V
I <sub>S</sub>	Maximum Body-Diode Continuous Current <sup>B</sup>					105	Α
DYNAMIC	PARAMETERS				-		
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =15V, f =1MH <sub>Z</sub>			8313		pF
C <sub>oss</sub>	Output Capacitance				951		
$C_{rss}$	Reverse Transfer Capacitance				897		
SWITCHIN	NG PARAMETERS						
Q <sub>g</sub> (10V)	Total Gate Charge	$V_{GS} = 10V, V_{DS} = 15V, I_{D} = 50A$			160		
$Q_{gs}$	Gate Source Charge				18		nC
$Q_{gd}$	Gate Drain Charge				34		
t <sub>D(on)</sub>	Turn-On Delay Time	$V_{GS} = 10V, V_{DS} = 15V, I_{D} = 50A,$ $R_{G} = 3\Omega$			27		
t <sub>r</sub>	Turn-On Rise Time				25		ns
$T_{D(off)}$	Turn-Off Delay Time				90		113
t <sub>f</sub>	Turn-Off Fall Time				40		
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =30A, di/dt =100A/μs			43		ns
Q <sub>rr</sub>	Body Diode Reverse Recovery Charge				40		nC

- A. Single pulse width limited by maximum junction temperature.
- B. The maximum current rating is package limited.
- C. The power dissipation  $P_D$  is based on  $T_{J(MAX)} = 175$ °C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

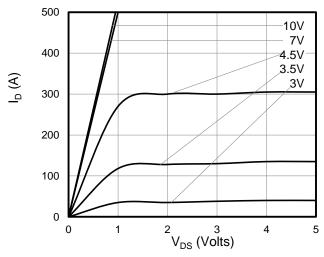
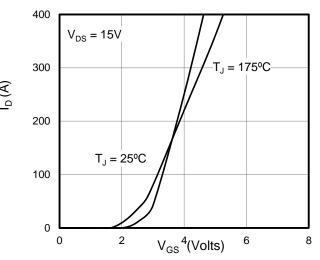


Figure 1: On-Region Characteristics



**Figure 2: Transfer Characteristics** 

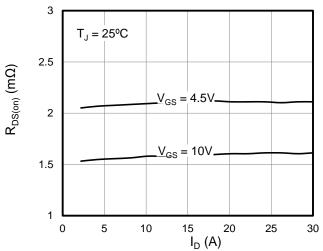


Figure 3: On-Resistance vs. Drain Current

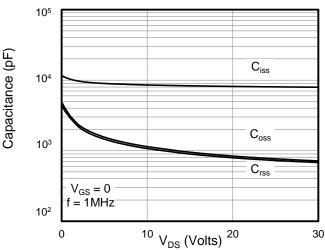


Figure 4: Capacitance Characteristics

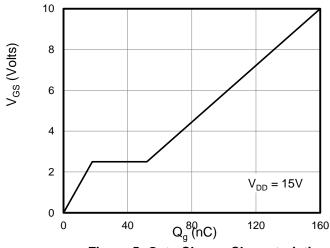


Figure 5: Gate Charge Characteristics

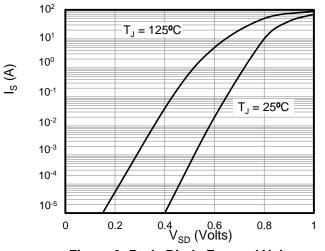
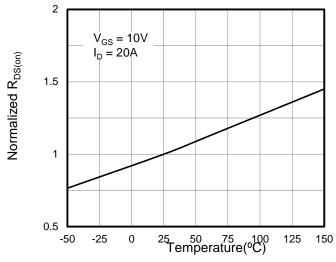


Figure 6: Body Diode Forward Voltage

 $Z_{\theta, JC}$  Normalized Transient Thermal Resistance

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### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



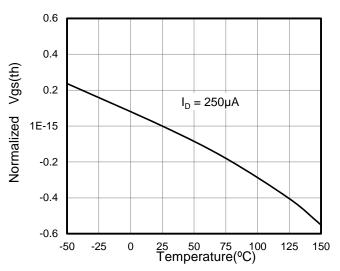
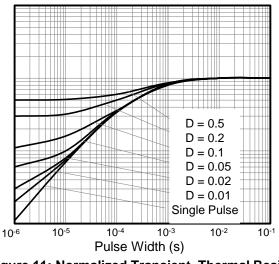


Figure 7: On-Resistance vs. Junction Temperature

Figure 8: Vgs(th) vs. Junction Temperature



I<sub>D</sub> (Amps)

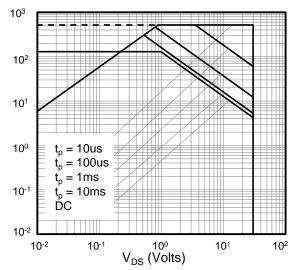


Figure 11: Normalized Transient Thermal Resistance

Figure 12: Safe Operating Area



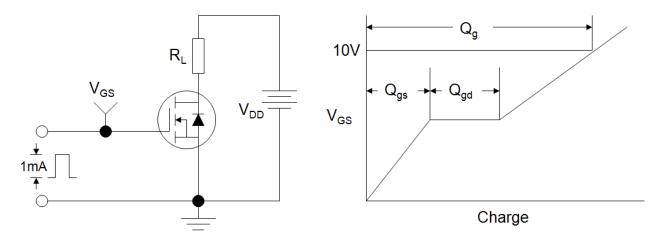


Figure A: Gate Charge Test Circuit and Waveforms

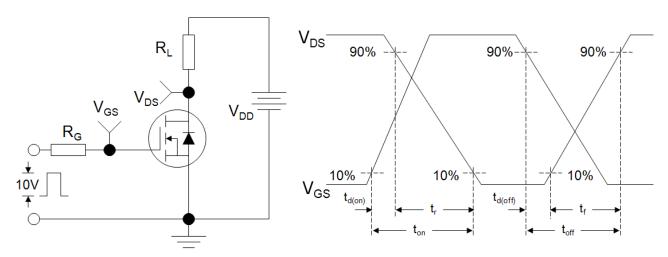


Figure B: Resistive Switching Test Circuit and Waveforms

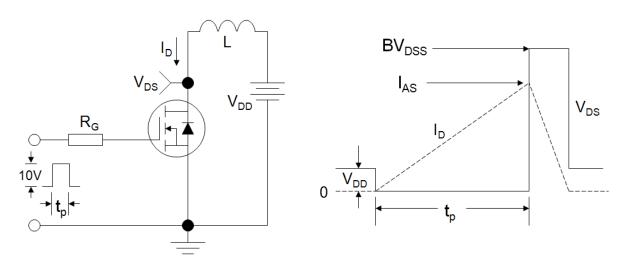
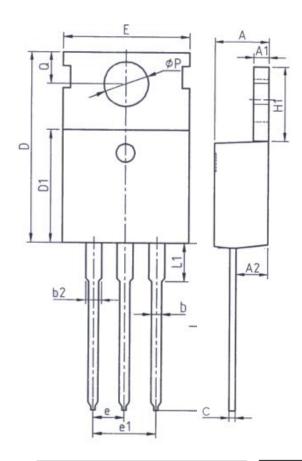
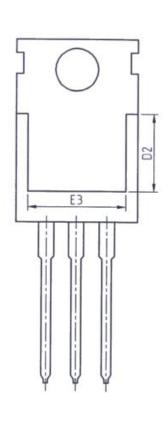


Figure C: Unclamped Inductive Switching (UIS) Test Circuit and Waveforms



# **TO-220**





Unit: mm				
Symbol	Min.	Max.		
Α	4. 37	4. 77		
A1	1. 25	1. 45		
A2	2. 20	2. 60		
b	0. 70	0. 95		
b2	1. 17	1. 47		
С	0.40	0. 65		
D	15. 10	16. 10		
D1	8. 80	9. 40		
D2	5. 50	_		

Unit: mm				
Symbol	Min. Max.			
E	9. 70	10. 30		
E3	7. 00	_		
е	2. 54BSC			
e1	5. 08BSC			
H1	6. 25	6. 85		
L	12. 75	13.80		
L1	-	3. 40		
P	3. 40	3. 80		
Q	2. 60	3. 00		



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